INTERNATIONAL ELECTROTECHNICAL COMMISSION COMMISSION ÉLECTROTECHNIQUE INTERNATIONALE

IEC 60384-14 Edition 5.0 2023-01 IEC 60384-14 Édition 5.0 2023-01

FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –

Part 14: Sectional specification – Fixed capacitors for electromagnetic interference suppression and connection to the supply mains

CONDENSATEURS FIXES UTILISÉS DANS LES ÉQUIPEMENTS ÉLECTRONIQUES –

Partie 14: Spécification intermédiaire – Condensateurs fixes pour la suppression des interférences électromagnétiques et la connexion au réseau d'alimentation

CORRIGENDUM 1

Corrections to the French version appear after the English text.

Les corrections à la version française sont données après le texte anglais.

Document Preview

3.1.9

by-pass capacitor

In Note 1 to entry, replace "Y2-capacitors" with "Y-capacitors".

5.3.1.4 Applied voltage

In the NOTE, replace "6.6.3.4" with "6.2.3.4".

Table 7 - Resistance to soldering heat - Requirements

In the third column of the third row, replace "Table 14, or Table 15" with "Table 17 or Table K.3".

5.13.2 Initial measurements

In the first paragraph, replace "Table 14 or Table 15" with "Table 17 or Table K.3".

Table 10 - Damp heat, steady state - Requirements for samples tested without voltage applied

In the third column of the third row, replace "Table 16" with "Table 15".

5.16.2 Initial measurements

In the first sentence, replace "Table 15 or Table K.1" with "Table 17 or Table K.3".

5.18.1.1 General

Replace the last paragraph with the following:

For surface mount capacitors consisting of ceramic and metal only, the passive flammability test may be omitted.

5.18.2.1 General

In the first paragraph, replace "the following alternative test method can be used" with "the following alternative test method may be used".

6.2 Information for marking

In item f), add the closing bracket after the second symbol for direct voltage.

8.4.3.1 Sampling

In the second sentence of the second paragraph, replace "footnote h to Table 16" with "footnote h to Table K.1".

Table 15 - Sampling plan - Tests concerning safety requirements only

In column "Subclause of this document" of Group 3, replace "5.15.4", "5.15.5" and "5.15.6" with "5.15.5", "5.15.6" and "5.15.7", respectively.

Table 16 - Test schedule and sampling plan for lot-by-lot tests

In the first sentence in the fifth row, replace "Group A2" with "Group A1".

Table 17 - Test schedule for safety tests only

In Group 0 in the "Performance requirements" column, the requirement "As in Table 5" is on the line "5.3.3 Tangent of loss angle". Move "As in Table 5" to line "5.3.5, Insulation resistance".

In Group 3 in the "Performance requirements" column, the requirement "No permanent breakdown or flashover" is on the line "5.15 Endurance". Move "No permanent breakdown or flashover" to line "5.14.4 Requirements".

In Group 3 in the "Conditions of test" column, on the line "5.15 Endurance", delete the reference to 5.15.4.

In Group 3, in the "Subclause number and test" column and in the "Conditions of test" column of the row "5.15.8 Final inspection and measurements", replace both occurrences of "5.15.8" with "5.15.9".

In Group 7, "Conditions of test" column, replace "See 5.19.2" with "See 5.19.1 and 5.19.2".

Table 18 - Assessment level

Add footnote c to "C1B" in the "Inspection subgroup" column.

F.2 Test and measurement procedures

In the third and fourth paragraphs, replace "5.3" and "5.4" with "5.4" and "5.5", respectively.

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Table F.1 – Test schedule and sampling plan for safety test of surface mount capacitors

In the second column of the fourth row, replace "10" with "12".

In the second bullet point, replace "prescribed in 5.15.7" with "specified in 5.15.8".

H.3 Additional requirement for use of X- and Y-capacitors in DC applications

In the first sentence, replace "Table 13" with "Table 15".

J.2.4 Conductors between terminals

Replace the second sentence of the second paragraph with "Further information about the use of protective coatings and design requirements for circuit boards can be found in IEC 60664-3".

Table K.1 Sampling plan – Safety and performance tests qualification approval – Assessment level DZ

In footnote i, replace "5.15.7" with "5.15.8".

Table K.3 – Test schedule for safety and performance tests qualification approval – Assessment level DZ

In Group 1A, in row "5.2 Dimensions (detail)", replace "Table 13" with "Table 3".

In Group 1B, replace the second occurrence of "5.7.2 Final inspection" with "5.8.3 Final inspection".

In Group 2, row "5.13.3 Test conditions", replace the content of the cell in the "Destructive" column with "Half of the sample with $U_{\rm R}$ applied; the other half with no voltage applied".

In Group 3, replace "5.15.8 Final measurements" with "5.15.9 Final measurements". Replace the five occurrences of "Table 12" with "Table 3".

In Group 4, replace the four occurrences of "Table 13" with "Table 14".

Table K.4 - Assessment level

In the "Inspection subgroup" column, add footnote c to "C1B".

Table X.1 - Reference to IEC 60384-14 for clause/subclause or annex

In the second column of the header row, replace "IEC 60384-14:20xx" with "IEC 60384-14:2023".

https://stan.dn row. "3.5.1.2", replace "3.5.1.2" with "3.5.1.2.2" and "K.2.3" with "K.3.3".d/jec-60384-14-2023-cor1-2024

In row "4.14.1.1", replace "5.15.2.2" with "5.15.3".

In row "4.14.2 to 4.14.7", replace "5.15.3 to 5.15.8" with "5.15.4 to 5.15.9".

Table X.2 - Reference to IEC 60384-14 for figure/table

In the second column of the header row, replace "IEC 60384-14:20xx" with "IEC 60384-14:2023".

In the row "Table 3", replace "Table 14" with "Table 15".

In the row "Table 5 upper part", replace "Table 15" with "Table 16".

In the row "Table 6", replace "Table 16" with "Table 17".

In the row "Table 8", replace "Table 17 and Table K.4" with "Table 18 and Table K.4".

In the row "-" below the row "Table 14 and Table 15", replace "Table 11" with "Table 11 and Table 12".